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| INFORMATION DISCLOSURE<br>CITATION IN AN APPLICATION<br><br>(PTO-1449) |  |  |         |         |                 | ATTY. DOCKET NO.<br>2336-242    |             | U.S. APPLICATION NO.<br>Not yet assigned |  |
|  |  |  |         |         |                 | APPLICANT<br>Sun Woon KIM       |             | 10/776,270                               |  |
|  |  |  |         |         |                 | FILING DATE<br>herewith 2/12/04 |             | GROUP<br>2818                            |  |
| U.S. PATENT DOCUMENTS  |  |  |         |         |                 |                                 |             |  |  |
| EXAMINER'S INITIALS  |  | PATENT NO.   | DATE    | NAME    | CLASS           | SUBCLASS                        | FILING DATE |  |  |
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| FOREIGN PATENT DOCUMENTS   |  |  |         |         |                 |                                 |             |  |  |
| EXAMINER'S INITIALS  |  | PATENT NO.   | DATE    | COUNTRY | CLASS           | SUBCLASS                        | Translation |  |  |
|  |  |  |         |         |                 |                                 | Yes         | No                                       |  |
| TH   |  | WO 00/76004 A1   | 12/2000 | WIPO    |                 |                                 | Abstract    |  |  |
|  |  |  |         |         |                 |                                 |             |  |  |
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| OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)       |  |  |         |         |                 |                                 |             |  |  |
| TH   |  | "Spiral Growth of IngaN Nanoscale Islands on GaN" by Keller et al.; Japanese Journal of Applied Physics, Vol. 37, pgs. L431-434, c. 1998 |         |         |                 |                                 |             |  |  |
|  |  |  |         |         |                 |                                 |             |  |  |
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| EXAMINER   |  |  |         |         | DATE CONSIDERED |                                 |             |  |  |
| TU TU HIO  |  |  |         |         | Apr. 2005       |                                 |             |  |  |

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.